# Characterization of the secondary light from MSGC in CF4: Preliminary results

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#### Content

- Setup
- α-source and primary current measurements
- MSGC operation stability
- Photons-per-electron ratios
- Secondary scintillation spectra
- Aging effects



PMT can "see" the whole light-emission region.

Point-source calculations are applicable: Counts\*R\*R is constant *vs*. R











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#### Read-out arrangements

• <u>Ammeter</u> in <u>cathode</u> line, cathode grounded, <u>anode</u> at +HV: Bad!



Anode voltage

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#### $\alpha$ -source



Too many alphas: Saturation effects already at gains of ~10!



An attenuator (GEM) is glued ~0.8 mm away from the surface on a metal frame. Conductive glue!

~3 ooo alphas/s



#### Primary current measurements



Primary ionization current:Uncovered source:2.0 nASource with GEM:**0.073 nA** 

Constant current in a broad range of grid and source voltages!

Measured at 1 bar where recombination is weak!

#### **MSGC** operation



After ~5 nA current noticeably reduces with time! Is Light/Current ratio constant? Gas aging effects were observed! Stability?

#### **Operation stability**



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#### **Photons-per-electron ratios**



Data in the graphs: from a fresh microstrip, photons in  $4\pi$ , assuming that all light is emitted on top of the anodes (90% reflectivity)!

If one assumes zero reflectivity: Total yield (UV + visible), "fresh" microstrip: ~0.035 photons/electron

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#### Photon / electron ratios



<u>Data from a "used" microstrip</u> UV: about 50% drop, Visible: about 20% drop Checked: Still good short-time reproducibility

(More on aging is at the end of the presentation)

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#### Secondary scintillation spectra



Fully <u>corrected for</u> the spectrometer + PMT <u>sensitivity</u>!

Average recording time is 5 hours

Intensity of the visible component of each spectrum is scaled using  $\Delta \sim 20\%$ fresh gas measurements with the spectrometer at 300 and 620 nm!

To provide an <u>absolute scale</u> for all spectra, they are <u>scaled</u> using <u>photons/electron</u> ratios for the <u>visible</u> component.

 $\Delta \sim 20\%$ 

#### Spectra: Comparison with primary



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### Aging effects

- Drop of Photons/electron ratios (20 50%)
- Increase of the current at the same voltages (still exponential, not just leakage!)
- Current jumps
- New "features" in Ph/el vs current graphs





## Aging effects

- Loss of reflectivity
- Damage to anodes Loss of some anodes?
- Debris deposition Change of field configuration Change of spatial charge
- Shift of the light-emitting region



Photo of the microstrip after completing this experimental run

#### Conclusions

- The secondary scintillation shows a weak dependence on the CF4 pressure. 3bar of CF4 gives the highest photons-per-electron ratios.
- At 3 bar CF4, an admixture of 2 bar of He gives a slight (~20%) enhancement of the UV emission and practically does not affect the visible emission.
- Photons-per-electron ratios (assuming no reflectivity at the microstrip!) are

about **0.020** in the UV and

about 0.015 in the visible

• The spectral profiles of the secondary emission in the UV and in the visible are similar to the corresponding profiles of the primary emission in the presence of a strong electric field.

#### Outlook

- A similar study has to be performed at a lower flux of the primary electrons!
- Gas chamber has to be improved and the effect of impurities on the aging has to be studied.
- Reliable uncertainties are still to be calculated.
- Additional measurements with improved statistics have to be performed prior publication of the final results.